

Notice of References Cited	Application/Control No. 10/564,658	Applicant(s)/Patent Under Reexamination BECHTEL ET AL.	
	Examiner Matthew W. Such	Art Unit 2891	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,639,358	10-2003	Ishikawa et al.	313/504
*	C	US-6,894,431	05-2005	Yamazaki et al.	313/498
*	D	US-7,049,742	05-2006	Jeong et al.	313/506
*	E	US-2003/0213955	11-2003	Noguchi et al.	257/59
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*	N	EP 888035 A1	12-1998	European Patent	HOSOKAWA et al.	
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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